

Applications

- Military SATCOM Terminals
- Commercial SATCOM Terminals
- Point-to-Point Digital Radio
- Point-to Multipoint Digital Radio

Product Features

- Frequency Range: 27 - 31 GHz
- Pout: 36.5 dBm at $P_{IN} = 14$ dBm
- PAE: 25 % CW
- Small Signal Gain: 25 dB
- IM3: -35 dBc @ 25 dBm Pout/Tone
- Bias: $V_D = 20$ V, $I_{DQ} = 140$ mA, $V_G = -3$ V Typical
- Package Dimensions: 7 x 7 x 1.3 mm

General Description

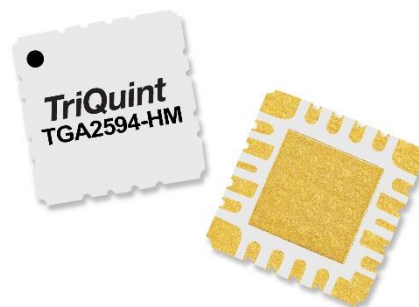
TriQuint's TGA2594-HM is a packaged power amplifier fabricated on TriQuint's 0.15um GaN on SiC process. Operating from 27 to 31 GHz, the TGA2594-HM achieves 36.5 dBm saturated output power with a power-added efficiency of 25%, and 25 dB small signal gain.

The TGA2594-HM is offered in a hermetically sealed 22-lead 7x7 mm ceramic QFN designed for surface mount to a printed circuit board. The package has a Cu base, offering superior thermal management. The TGA2594-HM is ideally suited to support both commercial and military applications.

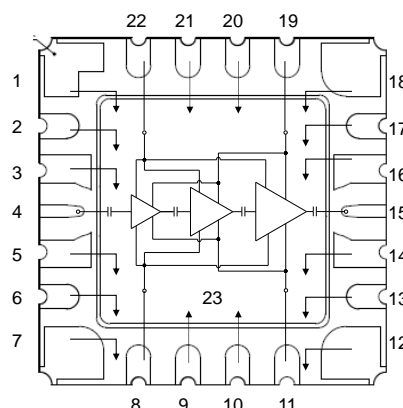
Both RF ports have integrated DC blocking capacitors and are fully matched to 50 Ohms.

Lead free and RoHS compliant.

Evaluation Boards are available upon request.



Functional Block Diagram



Pad Configuration

Pad No.	Symbol
1-3, 5-7, 9,10,12-14, 16-18, 20, 21, 23	GND
4	RF _{IN}
8, 11	NC
15	RF _{OUT}
19	V _D
22	V _G

Ordering Information

Part	ECCN	Description
TGA2594-HM	3A001.b.2.c	27 – 31 GHz GaN Power Amplifier

Absolute Maximum Ratings

Parameter	Value
Drain Voltage (V_D)	22.5 V
Gate Voltage Range (V_G)	-5 to 0 V
Drain Current (I_D)	1.4 A
Gate Current (I_G)	85 °C: -3 to 17 mA
Power Dissipation (P_{DISS}), 85°C	15 W
Input Power, CW, 50 Ω , (P_{IN})	30 dBm
Channel Temperature (T_{CH})	275 °C
Mounting Temperature (30 Seconds)	260 °C
Storage Temperature	-55 to 150 °C

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions

Parameter	Value
Drain Voltage (V_D)	20 V
Drain Current (I_{DQ})	140 mA
Drain Current Under RF Drive (I_{D_DRIVE})	See plots p. 7
Gate Voltage (V_G)	-3 V (Typ.)
Gate Current Under RF Drive (I_{G_DRIVE})	See plots p. 7
Temperature (T_{BASE})	-40 to 85 °C

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Electrical Specifications

Test conditions unless otherwise noted: 25 °C, $V_D = 20$ V, $I_{DQ} = 140$ mA, $V_G = -3$ V Typ, CW.

Parameter	Min	Typical	Max	Units
Operational Frequency Range	27		31	GHz
Small Signal Gain		25		dB
Input Return Loss		> 5		dB
Output Return Loss		> 5		dB
Output Power @ $P_{in} = 14$ dBm		36.5		dBm
Power Added Efficiency @ $P_{in} = 14$ dBm		25		%
IM3 ($P_{out}/tone = 25$ dBm/Tone)		-35		dBc
IM5 ($P_{out}/tone = 25$ dBm/Tone)		-43		dBc
Small Signal Gain Temperature Coefficient		-0.05		dB/°C
Output Power Temperature Coefficient		-0.04		dBm/°C

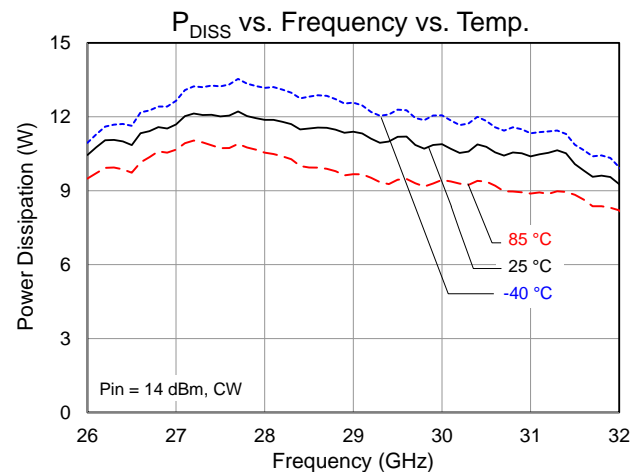
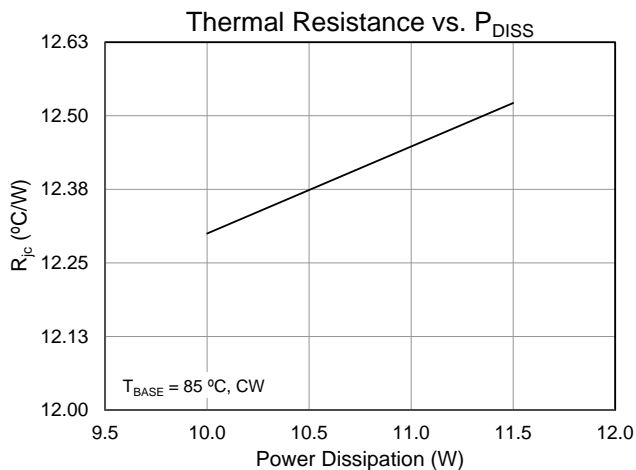
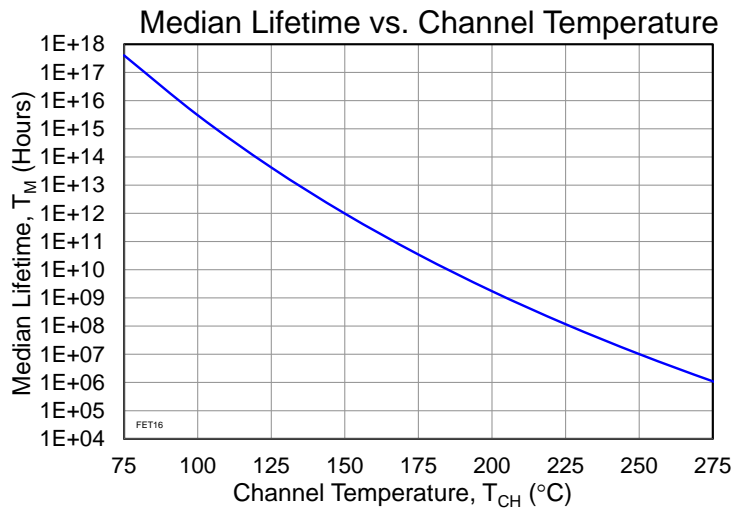
Thermal and Reliability Information

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ_{JC}) ⁽¹⁾	$T_{BASE} = 85^{\circ}\text{C}$, $V_D = 20\text{ V}$ (CW)	10.3	$^{\circ}\text{C/W}$
Channel Temperature (T_{CH}) (Under RF drive)	At Freq = 29 GHz, $P_{IN} = 14\text{ dBm}$: $I_{DQ} = 140\text{ mA}$, $I_{D_Drive} = 640\text{ mA}$	177	$^{\circ}\text{C}$
Median Lifetime (T_M)	$P_{OUT} = 36\text{ dBm}$, $P_{DISS} = 9\text{ W}$	2.4E+10	Hrs

Notes:

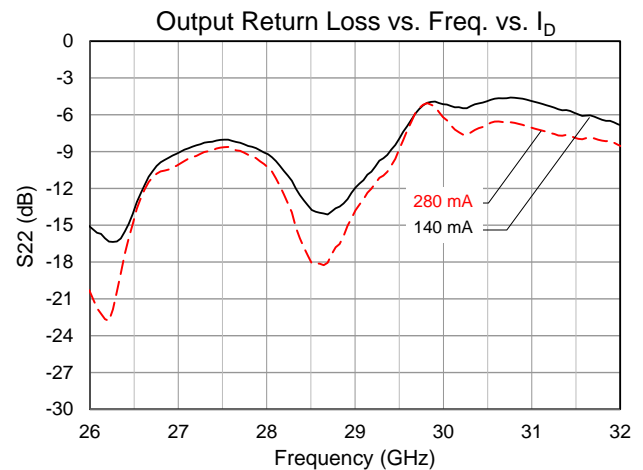
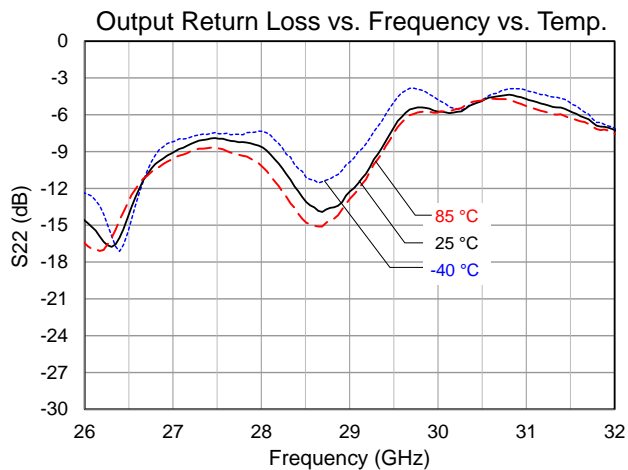
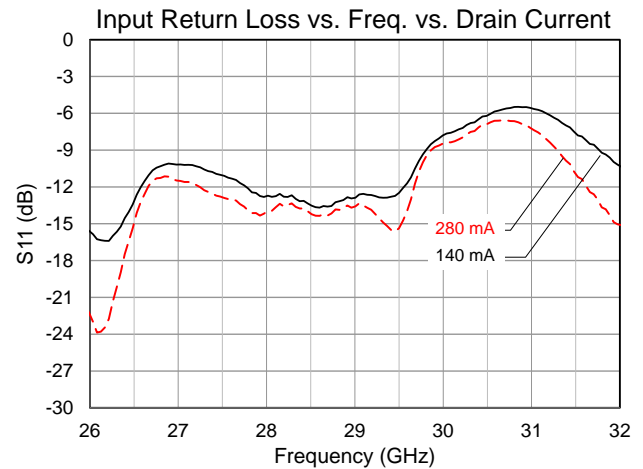
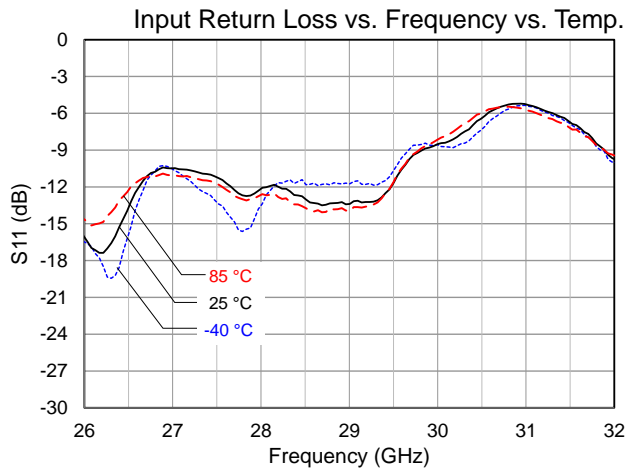
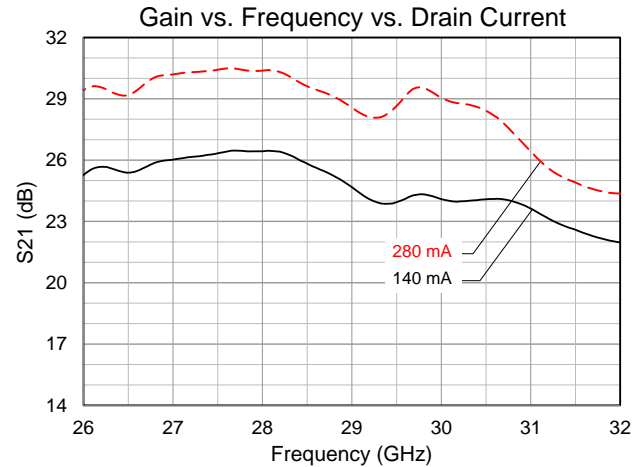
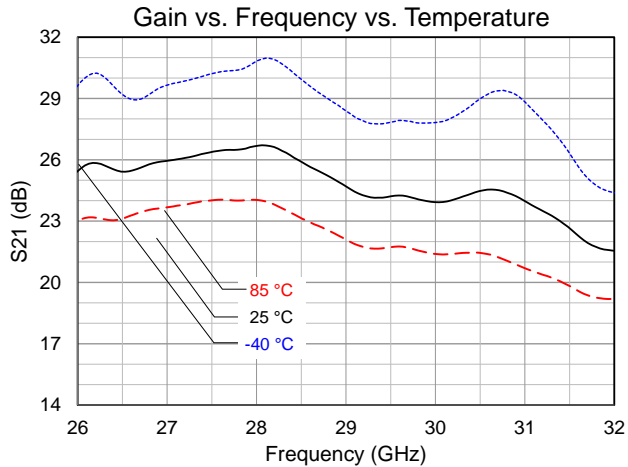
1. Thermal resistance measured to back of package.

Test Conditions: $V_D = 22\text{ V}$; Failure Criteria = 10% reduction in I_{D_MAX}



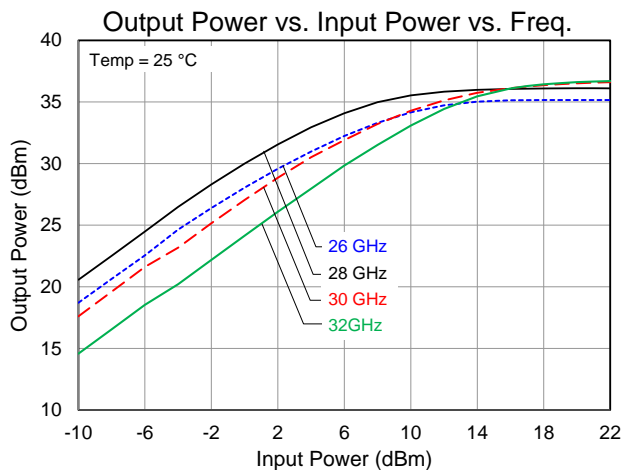
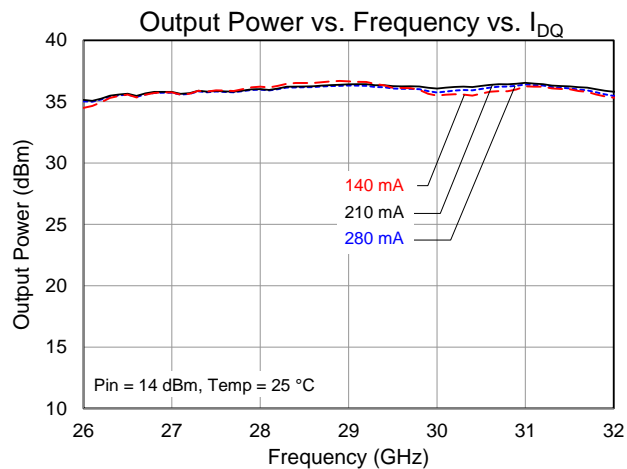
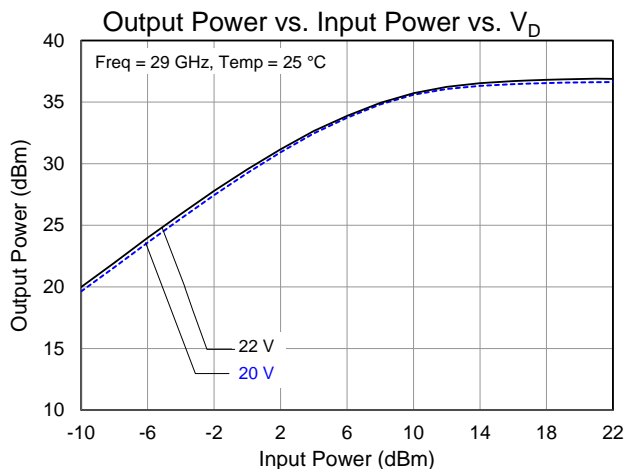
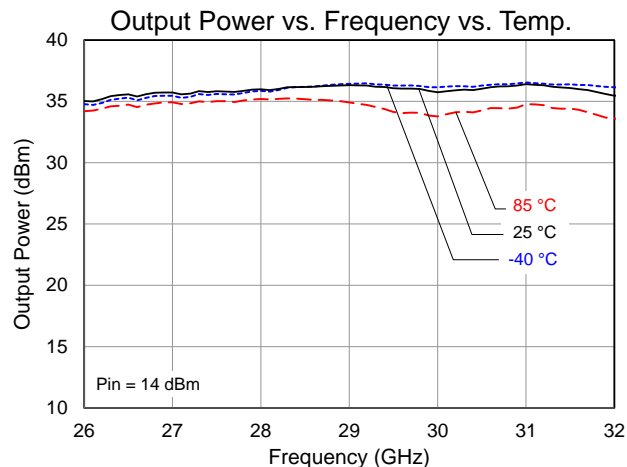
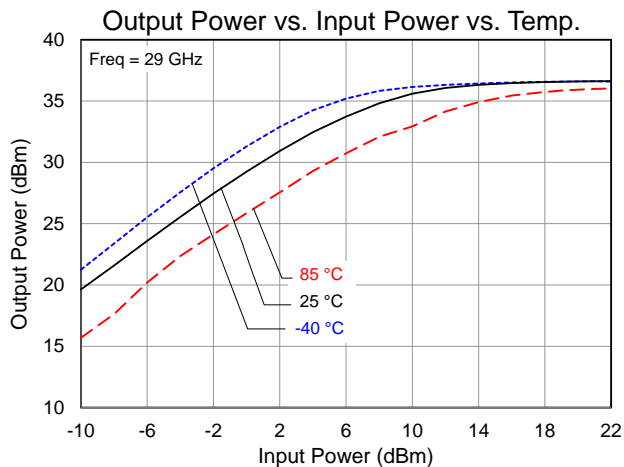
Typical Performance: Small Signal

Conditions unless otherwise specified: $V_D = 20$ V, $I_{DQ} = 140$ mA, $V_G = -3$ V Typical, CW.



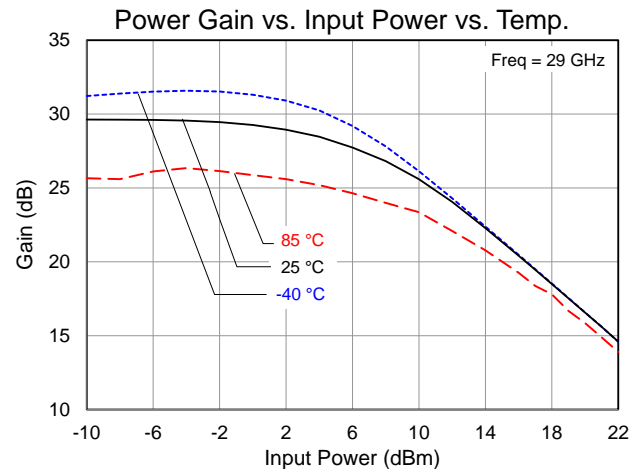
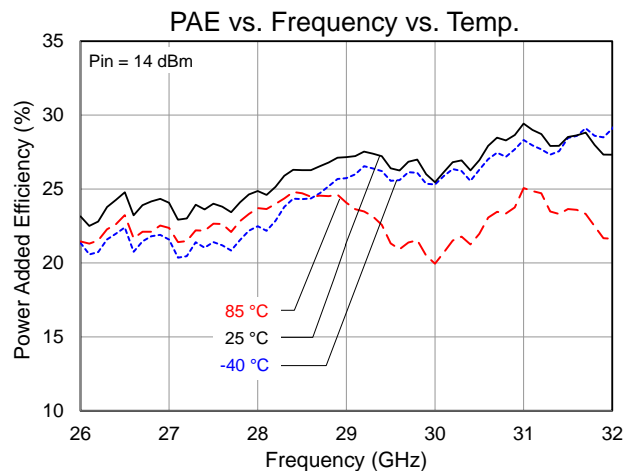
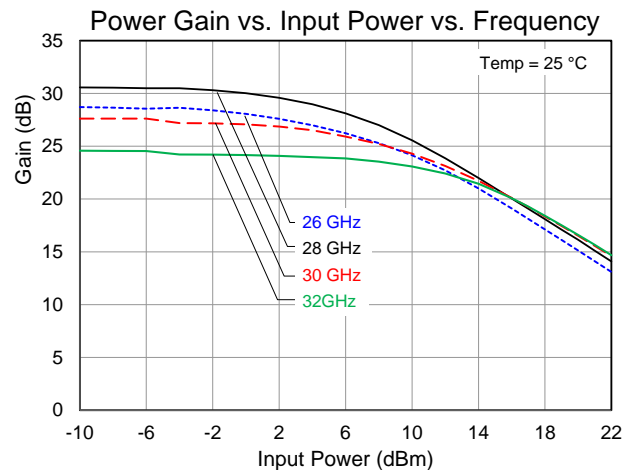
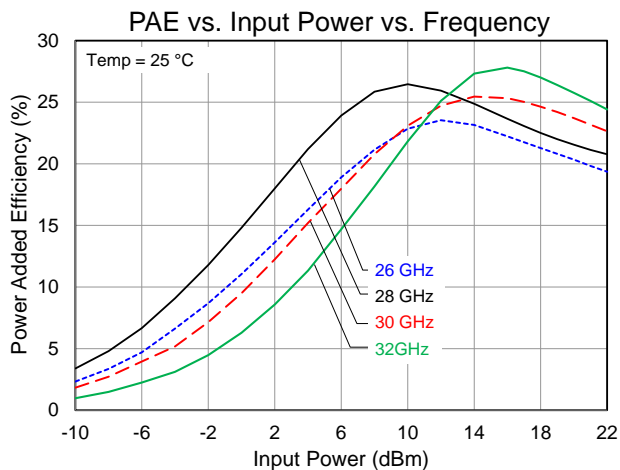
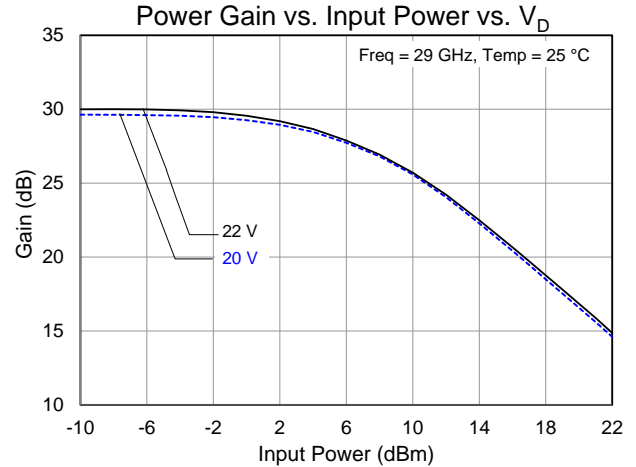
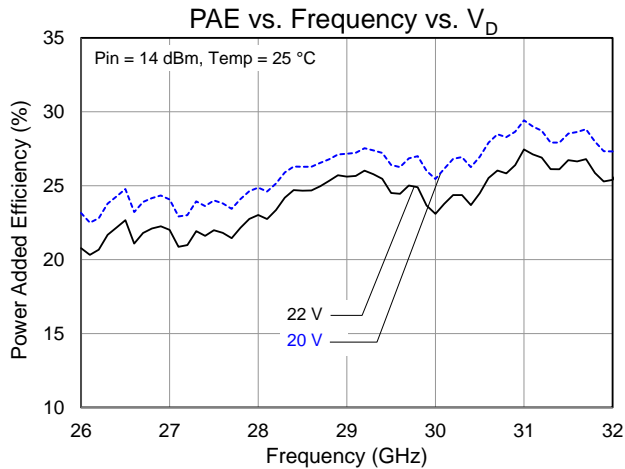
Typical Performance: Large Signal

Conditions unless otherwise specified: $V_D = 20\text{ V}$, $I_{DQ} = 140\text{ mA}$, $V_G = -3\text{ V}$ Typical, CW.



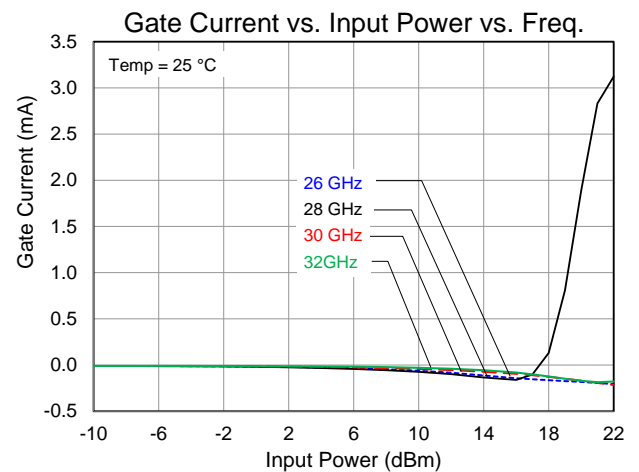
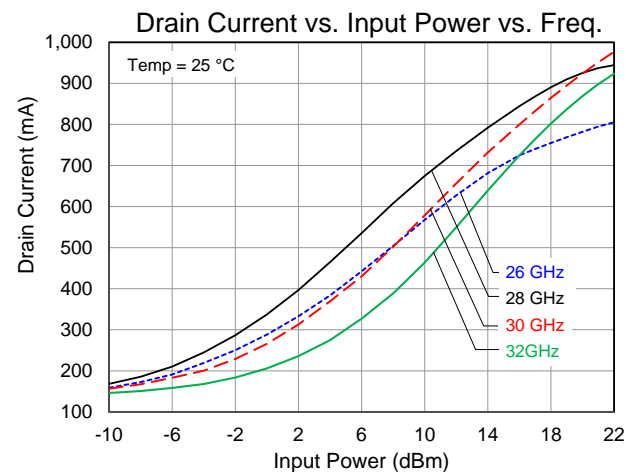
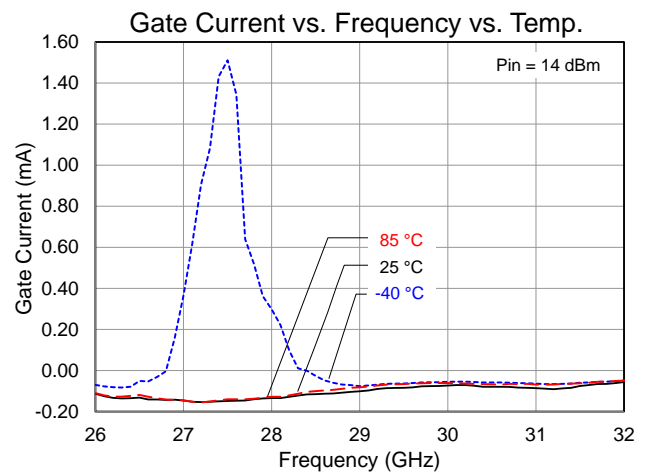
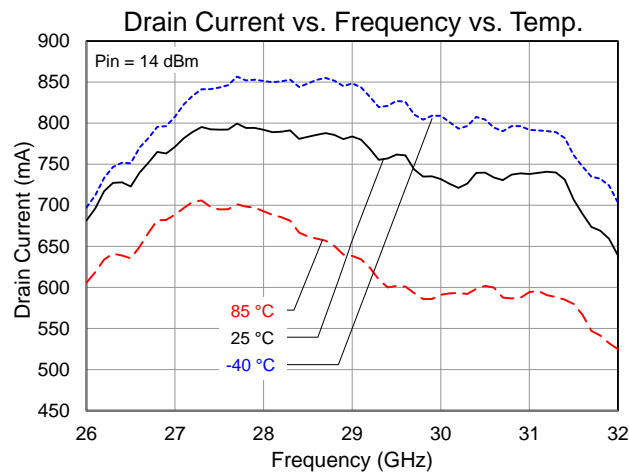
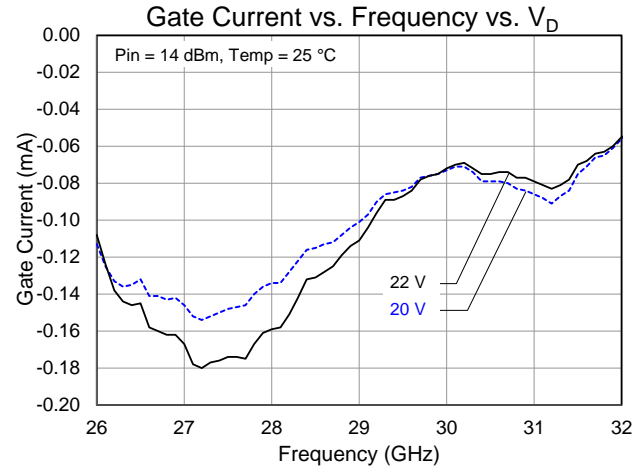
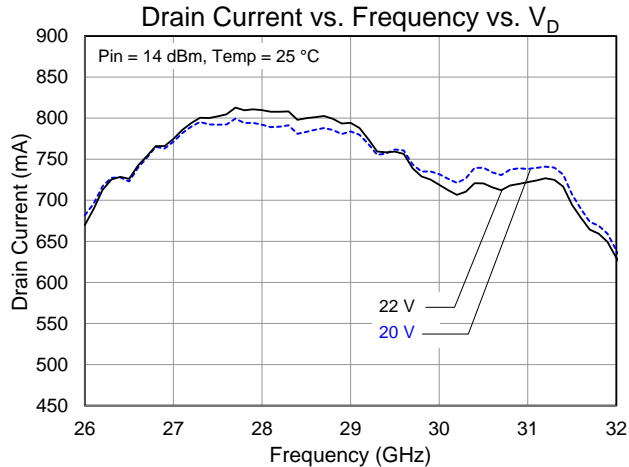
Typical Performance: Large Signal

Conditions unless otherwise specified: $V_D = 20\text{ V}$, $I_{DQ} = 140\text{ mA}$, $V_G = -3\text{ V}$ Typical, CW.



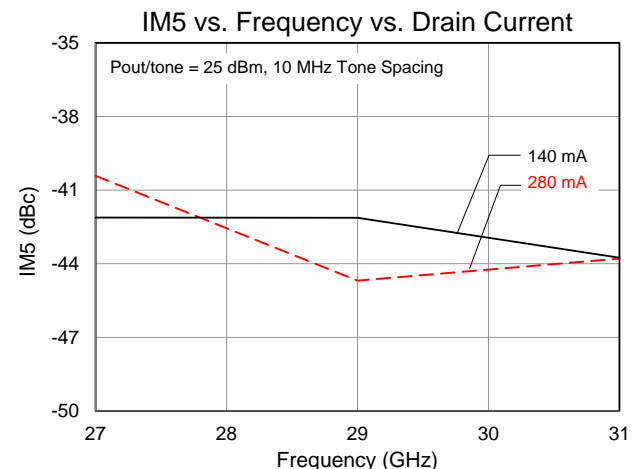
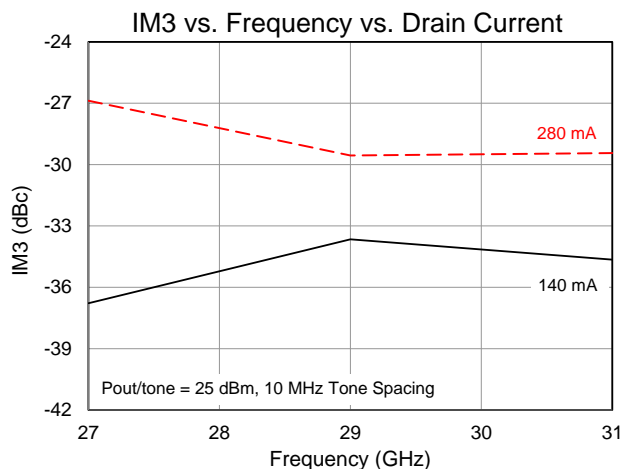
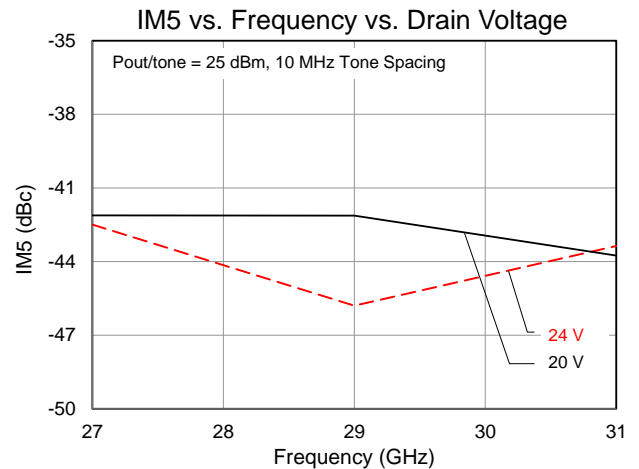
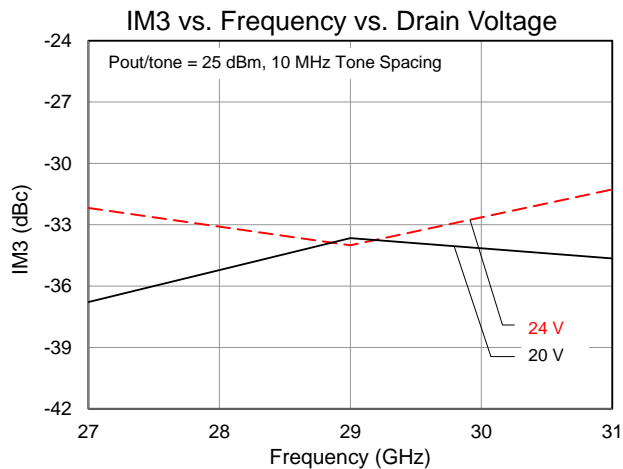
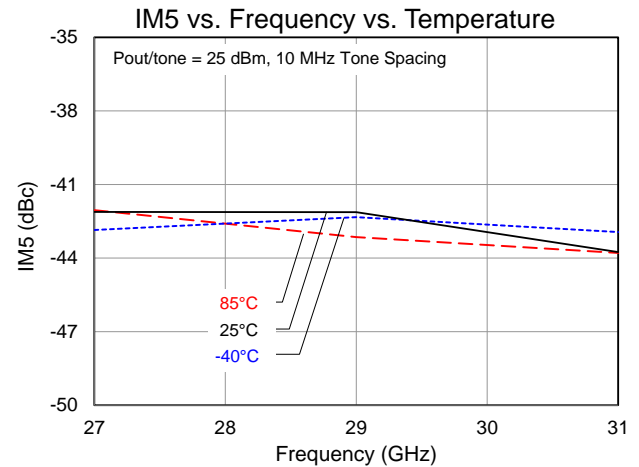
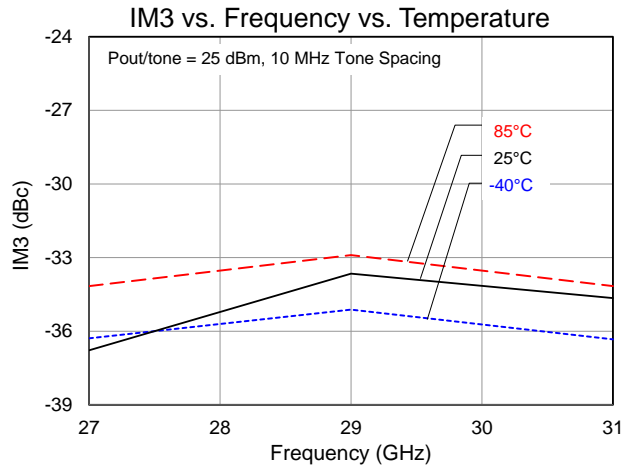
Typical Performance: Large Signal

Conditions unless otherwise specified: $V_D = 20$ V, $I_{DQ} = 140$ mA, $V_G = -3$ V Typical, CW.

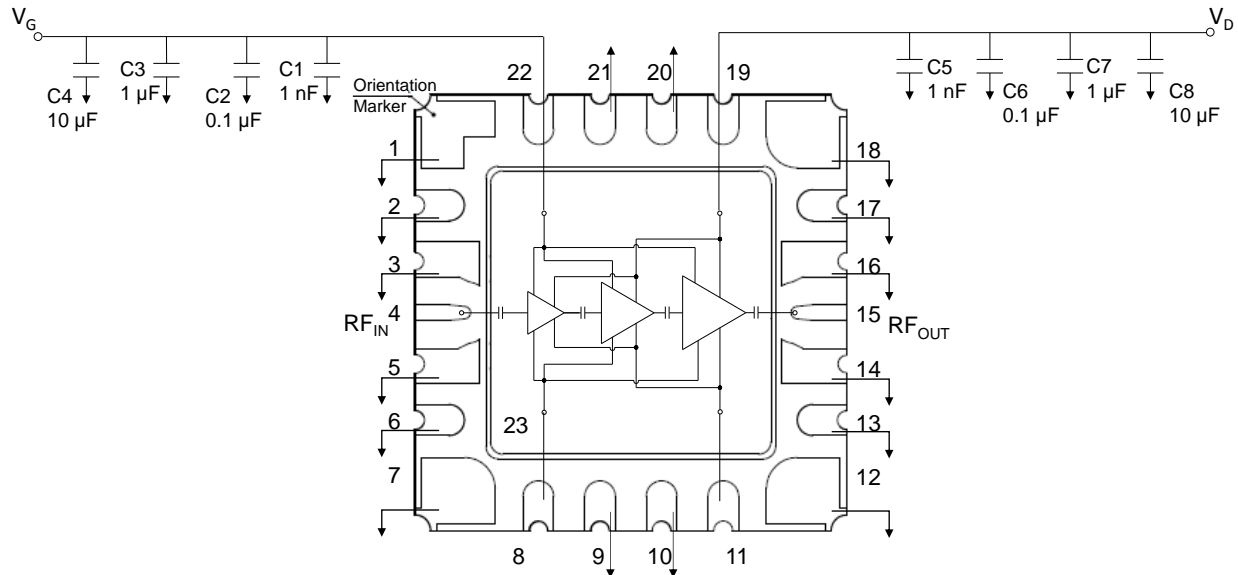


Typical Performance: Large Signal and Linearity

Conditions unless otherwise specified: $V_D = 20\text{ V}$, $I_{DQ} = 140\text{ mA}$, $V_G = -3\text{ V}$ Typical, CW.



Applications Information and Pad Layout



Bias-up Procedure

1. Set I_D limit to 1.2 A, I_G limit to 10 mA
2. Apply -5 V to V_G
3. Apply +20 V to V_D ; ensure I_{DQ} is approx. 0 mA
4. Adjust V_G until $I_{DQ} = 140$ mA ($V_G \sim -3$ V Typ.).
5. Turn on RF supply

Bias-down Procedure

1. Turn off RF supply
2. Reduce V_G to -5 V; ensure I_{DQ} is approx. 0 mA
3. Set V_D to 0 V
4. Turn off V_D supply
5. Turn off V_G supply

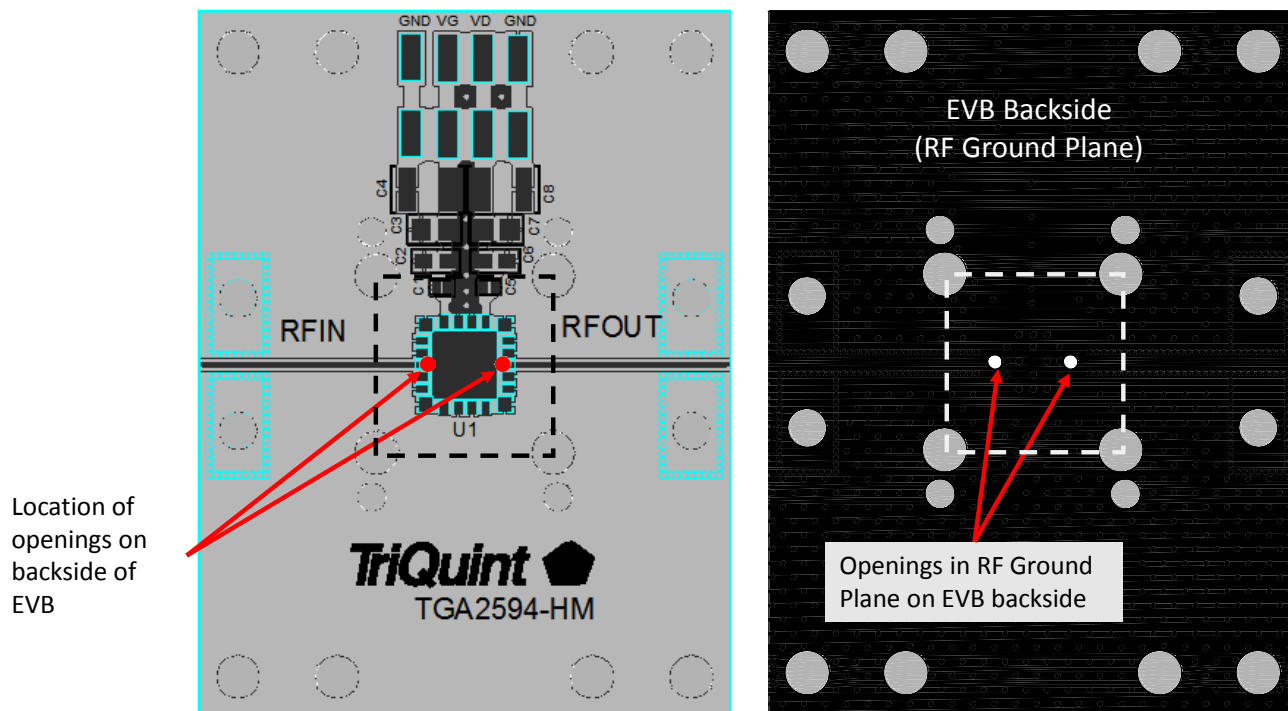
Pad Description

Pad No.	Symbol	Description
1-3, 5-7, 9,10,12-14, 16-18, 20,21,23	GND	Must be grounded on the PCB.
4	RF _{IN}	Output; matched to 50 Ω; DC blocked
8, 11	NC	For use with TQ EVB, do not connect (pins are connected internal to package)
15	RF _{OUT}	Input; matched to 50 Ω; DC blocked
19	V _D (1)	Drain voltage; Bias network is required; see recommended Application Information above.
22	V _G (2)	Gate Voltage; Bias network is required; see recommended Application Information above.

Notes:

1. If not using TQ EVB, V_D may be applied to either pin 11 or pin 19.
2. If not using TQ EVB, V_G may be applied to either pin 8 or pin 22.

Evaluation Board



Note existence of 1mm diameter opening on backside of EVB – the openings are required for all EVBs.
See Assembly Notes (page 11) for additional detail.

Bill of Material

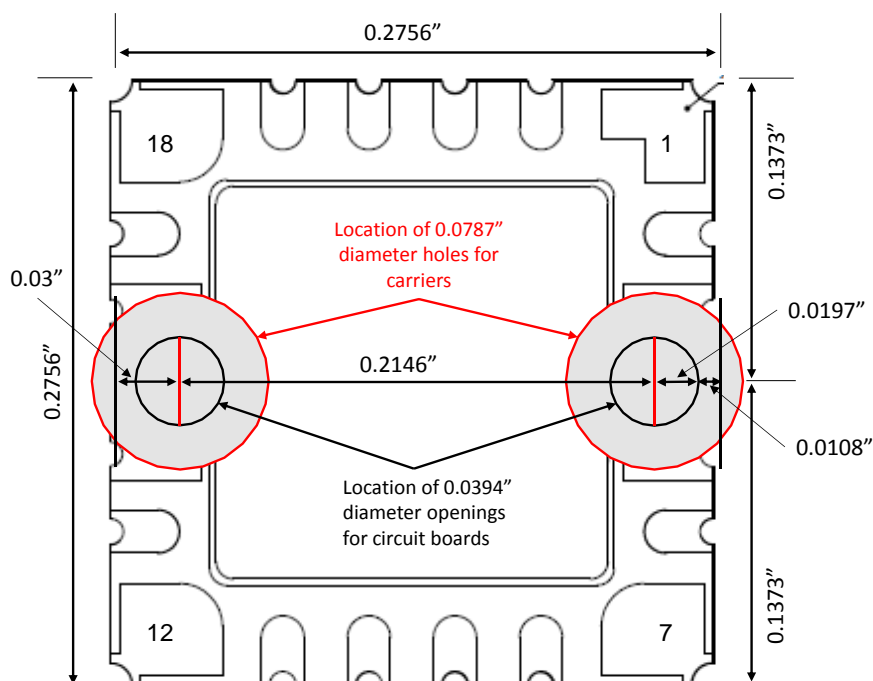
Reference Des.	Value	Description	Manuf.	Part Number
C1, C5	1 nF	Cap, 0402, 50 V, 10%, X7R	Various	
C2, C6	0.1 μ F	Cap, 0603, 50 V, 10%, X7R	Various	
C3, C7 (1)	1 μ F	Cap, 0805, 50 V, 10%, X7R	Various	
C4, C8 (1)	10 μ F	Cap, 1206, 50 V, 10%, X7R	Various	

Notes:

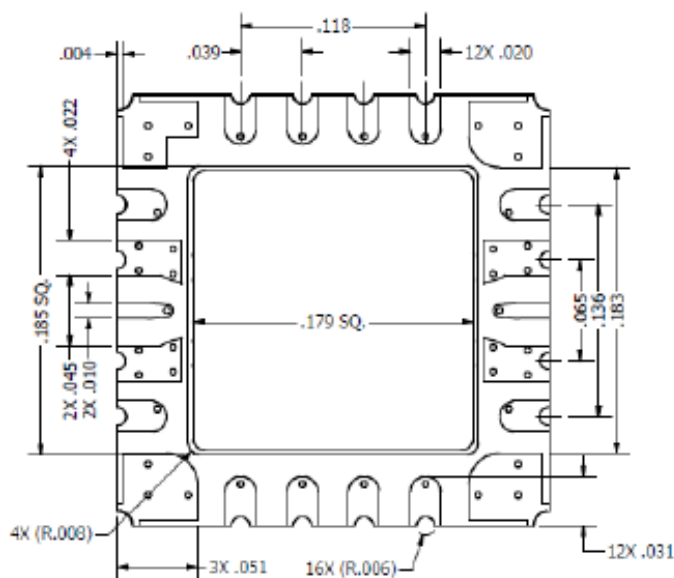
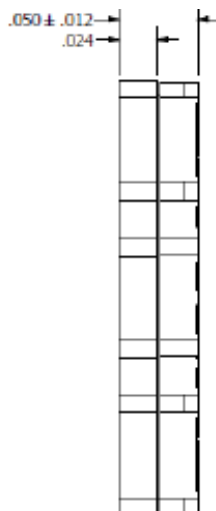
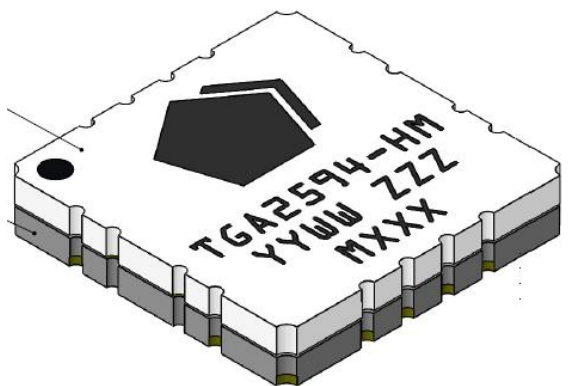
1. If the designated application is not sensitive to IM3, capacitors C3, C4, C7, and C8 may omitted.

Assembly Notes

1. Clean the board or module with alcohol. Allow it to dry fully.
2. AuSn solder is recommended for mounting the TGA2594-HM to the board.
3. Apply solder paste to each pin of the TGA2594-HM, and heat achieve reflow, being careful not to exceed the thermal budget.
4. Clean the assembly with alcohol.
5. To attain quoted RF performance, the following is required:
 - i. On the printed circuit board, there must be two 1mm (0.0394") diameter openings on the backside (RF Ground Plane) of the circuit board.
 - Location of the openings is contained in the TQ Evaluation Board layout.
 - The 1 mm diameter openings for the board are shown in the diagram below in reference to the base of the package.
 - ii. Use of a carrier plate with 2mm (0.0787") diameter holes.
 - The holes should be located with respect to the package pin-out as shown in the diagram below.
 - The holes should be 4mm deep.
6. To improve thermal performance, the following is recommended:
 - i. The use of a 4 mil indium shim between the circuit board and the carrier plate.
 - ii. The In shim should have the same hole diameter and positioning as the carrier plate (see diagram below for location with respect to the package backside).
 - iii. The holes should be machined fully through the In shim.



Mechanical Information



Units: inches

Tolerances: unless specified

x.xx = ± 0.01

x.xxx = ± 0.005

Materials:

Base: Copper

Lid: Ceramic

All metalized features are gold plated

Part is solder sealed

Marking:

2578: Part number

YY: Part Assembly year

WW: Part Assembly week

ZZZ: Serial Number

MXXX: Batch ID

Product Compliance Information

ESD Sensitivity Ratings



Caution! ESD-Sensitive Device

ESD Rating: TBD
Value: TBD
Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

MSL Rating

Level TBD at TBD°C convection reflow
The part is rated Moisture Sensitivity Level TBD at TBD°C
per JEDEC standard IPC/JEDEC J-STD-020.

ECCN

US Department of Commerce: 3A001.b.2.c

Solderability

Compatible with the latest version of J-STD-020, Lead-free solder, 260°C

RoHS Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- PFOS Free
- SVHC Free

Contact Information

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